Supporting Information

Synthesis of hierarchical structured Fe₂O₃ rod clusters with numerous empty nanovoids via the Kirkendall effect and their electrochemical properties for lithium-ion storage

Seung-Keun Park, Jae Hun Choi and Yun Chan Kang*

Department of Materials Science and Engineering, Korea University, Anam-Dong, Seongbuk-Gu, Seoul 136-713, Republic of Korea.

*Correspondence authors. E-mail: yckang@korea.ac.kr (Yun Chan Kang, Fax: (+82) 2-928-3584)



Fig. S1 Morphologies and crystal structure of FeSe₂ rod clusters: (a) SEM image, (b, c) TEM images, (d) HR-TEM image (e) SAED pattern, and (f) elemental mapping images.



Fig. S2 XRD patterns of FeSe₂, Fe₂O₃-A300 oxidized for 10 min, and Fe₂O₃-A300, -A400, -A500, and -A600 rod clusters oxidized for 3 hrs.



Fig. S3 SEM images of Fe₂O₃-A300, -A400, -A500, and -A600 rod clusters.



Fig. S4 Morphologies and crystal structure of Fe₂O₃-A300 rod clusters: (a, b) TEM images,

(c) HR-TEM image (d) SAED pattern, and (e) elemental mapping images.



Fig. S5 XPS survey scan of (a) Fe₂O₃-A400 and (b) Fe₂O₃-A500 rod clusters.



Fig. S6 TGA curves of Fe₂O₃-A400 and -A500 rod clusters.



Fig. S7 (a) N₂ adsorption and desorption isotherms and (b) BJH pore size distributions of FeSe₂, Fe₂O₃-A300, -A400, -A500, and -A600 rod clusters.



Fig. S8 CV curves of Fe₂O₃-A600 rod clusters obtained at 0.1 mV s⁻¹ in the potential range of 0.001 - 3.0 V for the first, second, and fifth cycles.



Fig. S9 SEM images of (a, b) Fe₂O₃-A400, (c, d) -A500, and (e, f) -A600 rod clusters after 100 cycles.

Equivalent circuit model



R_e: the electrolyte resistance, corresponding to the intercept of high frequency semicircle at Z' axis

Rf: the SEI layer resistance corresponding to the high-frequency semicircle

Q₁: the dielectric relaxation capacitance corresponding to the high-frequency semicircle

R_{ct}: the denote the charger transfer resistance related to the middle-frequency semicircle

 Q_2 : the associated double-layer capacitance related to the middle-frequency semicircle Z_w : the Li-ion diffusion resistance

Fig. S10 Randle-type equivalent circuit model used for AC impedance fitting.

Samples	Fe (wt %)	Se (wt %)	O (wt %)	Total
FeSe ₂ rod clusters	28.5	71.2	0.3	100
Fe ₂ O ₃ -A300	44.1	38.4	17.5	100
Fe ₂ O ₃ -A400	65.0	7.7	27.3	100
Fe ₂ O ₃ -A500	69.4	1.4	29.2	100
Fe ₂ O ₃ -A600	70.2	0.0	29.8	100

Table S1. Chemical composition of FeSe₂, and Fe₂O₃-A300, -A400, -A500, and A600 rod clusters (based on the EDX quantitative data)

Table S2. Electrochemical properties of the Fe_2O_3 materials with various structures as anode materials for LIBs.

Materials	Voltage range [V]	Current rate [A g ⁻¹]	Discharge capacity after cycling [mA h g ⁻¹]	Rate capability [mA h g ⁻¹] /[A g ⁻¹]	Ref
Porous Fe ₂ O ₃ rod clusters	0.001 - 3.0	1.0	1381 (200 th)	745 (10.0 A g ⁻¹)	Our work
Hollow Fe ₂ O ₃ spheres	0.05-3.0	0.2	710 (100 th)	-	1
Hierarchical hollow spheres composed of Fe ₂ O ₃ nanosheets	0.01-3.0	0.5	815 (200 th)	330 (5.0 A g ⁻¹)	2
Hierarchical Fe ₂ O ₃ microboxes	0.005-3.0	0.2	945 (30 th)	-	3
Hollow Fe ₂ O ₃ nanospheres	0.01-3.0	0.25	490 (50 th)	-	4
Hollow Fe ₂ O ₃ nanobarrels	0.01-3.0	0.5	916 (100 th)	403 (10.0 A g ⁻¹)	5
Multi-shelled hollow Fe2O3 spheres	0.05-3.0	0.4	861 (50 th)	294 (4.0 A g ⁻¹)	6
Graphene-constructed hollow Fe ₂ O ₃ spheres	0.01-3.0	0.1	950 (50 th)	640 (1.0 A g ⁻¹)	7
Carbon coated hollow Fe ₂ O ₃ sphere	0.01-3.0	0.3	950 (100 th)	-	8
Fe ₂ O ₃ nanorods	0.005-3.0	0.5	970 (100 th)	300 (5.0 A g ⁻¹)	9
Spindle-like Fe ₂ O ₃	0.01-3.0	0.2	911 (50 th)	424 (10.0 A g ⁻¹)	10
Fe ₂ O ₃ nanoparticle- loaded carbon nanofibers	0.05-2.8	0.05	488 (75 th)	288 (0.5 A g ⁻¹)	11
Fe ₂ O ₃ nano- assembled spindles	0.005-3.0	0.1	~900 (40 th)	430 (1.0 A g ⁻¹)	12

References

- 1. B. Wang, J. S. Chen, H. B. Wu, Z. Y. Wang and X. W. Lou, *J. Am. Chem. Soc.*, 2011, **133**, 17146-17148.
- 2. J. X. Zhu, Z. Y. Yin, D. Yang, T. Sun, H. Yu, H. E. Hoster, H. H. Hng, H. Zhang and Q. Y. Yan, *Energy Environ. Sci.*, 2013, **6**, 987-993.
- 3. L. Zhang, H. B. Wu, S. Madhavi, H. H. Hng and X. W. Lou, J. Am. Chem. Soc., 2012, 134, 17388-17391.
- 4. M. Sasidharan, N. Gunawardhana, M. Yoshio and K. Nakashima, *Ionics*, 2013, **19**, 25-31.
- 5. K. S. Lee, S. Park, W. Lee and Y. S. Yoon, ACS Appl. Mater. Interfaces, 2016, 8, 2027-2034.

- 6. Z. Padashbarmchi, A. H. Hamidian, H. W. Zhang, L. Zhou, N. Khorasani, M. Kazemzad and C. Z. Yu, *RSC Adv.*, 2015, **5**, 10304-10309.
- Y. W. Chen, J. Z. Wang, J. Z. Jiang, M. A. Zhou, J. Zhu and S. Han, *RSC Adv.*, 2015, 5, 21740-21744.
- 8. Z. J. Du, S. C. Zhang, J. F. Zhao, X. M. Wu and R. X. Lin, *J. Nanosci. Nanotechno.*, 2013, **13**, 3602-3605.
- 9. Y. M. Lin, P. R. Abel, A. Heller and C. B. Mullins, J. Phys. Chem. Lett., 2011, 2, 2885-2891.
- 10. X. Xu, R. Cao, S. Jeong and J. Cho, *Nano Lett.*, 2012, **12**, 4988-4991.
- 11. L. W. Ji, O. Toprakci, M. Alcoutlabi, Y. F. Yao, Y. Li, S. Zhang, B. K. Guo, Z. Lin and X. W. Zhang, *ACS Appl. Mater. Interfaces*, 2012, **4**, 2672-2679.
- 12. A. Banerjee, V. Aravindan, S. Bhatnagar, D. Mhamane, S. Madhavi and S. Ogale, *Nano Energy*, 2013, **2**, 890-896.